Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,908	MIZUE, TOSHIO
Examiner	Art Unit
Ellen Kim	2874

SEARCHED					
Class	Subclass	Date	Examiner		
385	88-92	7/25/2005	EK		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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